

Notice of References Cited	Application/Control No. 10/721,550	Applicant(s)/Patent Under Reexamination MIYASITA ET AL.	
	Examiner John B Nguyen	Art Unit 2819	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,496,549 B1	12-2002	Crawford, Richard D.	375/320
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NON-PATENT DOCUMENTS

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